

Notice of References Cited	Application/Control No. 10/634,351	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner RIP A. LEE	Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,105,038	04-1992	Chen et al.	585/10
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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